## Application/Control No. Applicant(s)/Patent Under Reexamination 09/868,871 MALIK ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Tae H. Yoon 1714 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-5,308,549 05-1994 Laermer et al. 252/399 Α US-В US-С US-D US-Ε US-F US-G US-Н US-1 US-J US-Κ US-US-М **FOREIGN PATENT DOCUMENTS**

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